	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	10085285	LEUBA ET AL.
	Examiner	Art Unit
	Phan, Thanh S	2833

	ORIGINAL	AL.	INTERNATIONAL	INTERNATIONAL CLASSIFICATION	
	CLASS	SUBCLASS	CLAIMED	NON-CLAIMED	LAIMED
368	88	8	G 0 4 B 37/00	G 0 4 C	21 / 00
	CROSS REFERENCE(S)	ENCE(S)			
CLASS	SUBCLASS (ONE SUBCLASS PER	SUBCLASS PER BLOCK)			
368	250				
	ill				
Thanh S. Phan	02/08/07	P AUSTIN BRADI EY	BADLEY	Total Claims Allowed:	s Allowed:
(Assistant Examiner)		SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800	INT EXAMINER INTER 2800	19	6
(Legal Instruments Examiner)	nts Examiner) (Date)	(F. Bladley (Primary Examiner)	12/11/07 (Date)	O.G. Print Claim(s)	O.G. Print Figure
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